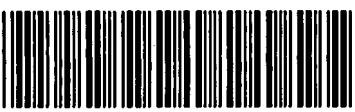


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10706060	NAKAMURA ET AL.
	Examiner	Art Unit
	Wendmagegn, Girumsew	2621

### SEARCHED

Class	Subclass	Date	Examiner
386	126	6/23/2007	gw
386	125	6/23/2007	gw
386	117	6/23/2007	gw
369		6/20/2007	gw

### SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	6/20/2007	gw
Inventor(s) search	6/23/2007	gw
Consulted James Fletcher; Thai Tran	6/19/2007	gw

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner